



## Integrated Power Module for Small Appliance Motor Drive Applications

### Description

IRSM836-035MB is a 3A, 500V Integrated Power Module (IPM) designed for advanced appliance motor drive applications such as energy efficient fans and pumps. IR's technology offers an extremely compact, high performance AC motor-driver in an isolated package. This advanced IPM offers a combination of IR's low  $R_{DS(on)}$  Trench MOSFET technology and the industry benchmark 3-phase high voltage, rugged driver in a small PQFN package. At only 12x12mm and featuring integrated bootstrap functionality, the compact footprint of this surface-mount package makes it suitable for applications that are space-constrained. Integrated over-current protection, fault reporting and under-voltage lockout functions deliver a high level of protection and fail-safe operation. IRSM836-035MB functions without a heat sink.

### Features

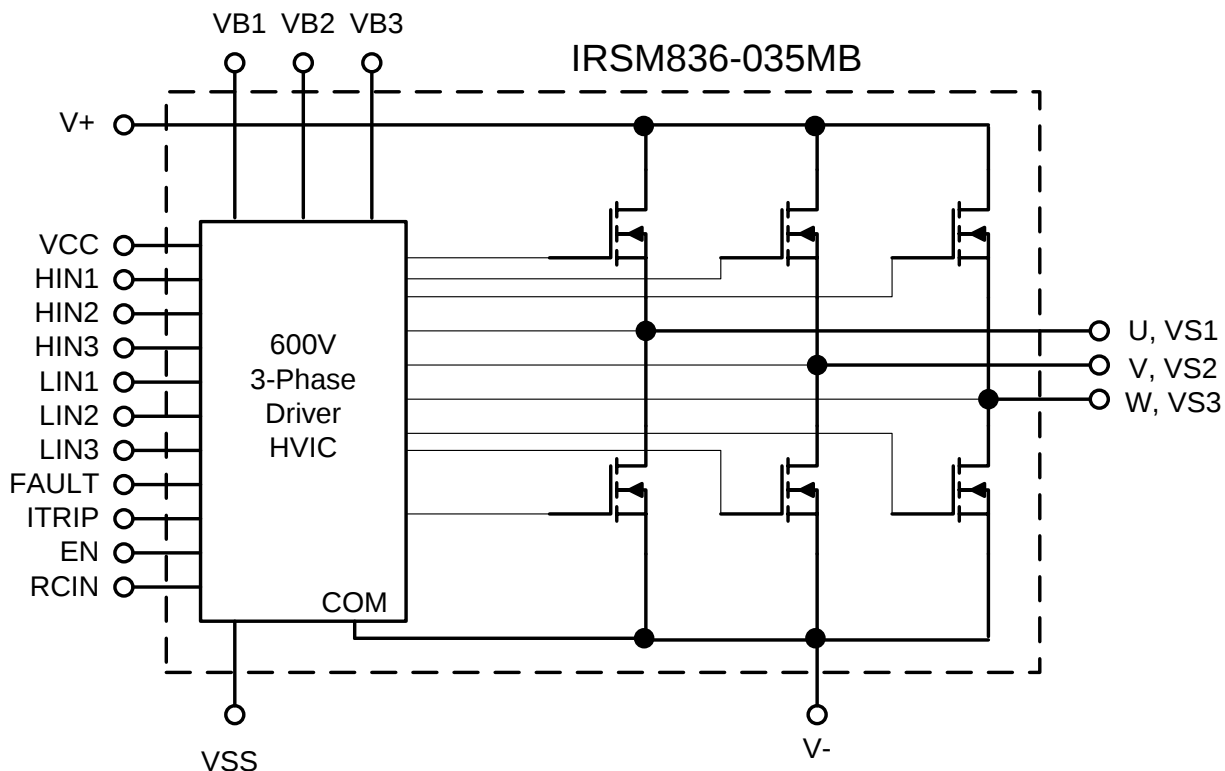
- Integrated gate drivers and bootstrap functionality
- Suitable for single shunt sensing
- Protection shutdown pin
- Low  $R_{DS(on)}$  Trench FREDFET
- Under-voltage lockout for all channels
- Matched propagation delay for all channels
- Optimized dV/dt for loss and EMI trade offs
- 3.3V Schmitt-triggered active high input logic
- Cross-conduction prevention logic
- Motor power range up to ~110W, without heat sink
- Isolation 1500VRMS min



| Base Part Number | Package Type           | Standard Pack |          | Orderable Part Number |
|------------------|------------------------|---------------|----------|-----------------------|
|                  |                        | Form          | Quantity |                       |
| IRSM836-035MB    | 27L<br>PQFN 12 x 12 mm | Tape and Reel | 2000     | IRSM836-035MBTR       |
|                  |                        | Tray          | 800      | IRSM836-035MB         |

All part numbers are PbF

## Internal Electrical Schematic



## Absolute Maximum Ratings

Absolute maximum ratings indicate sustained limits beyond which damage to the module may occur. These are not tested at manufacturing. All voltage parameters are absolute voltages referenced to VSS unless otherwise stated in the table.

| Symbol                  | Description                                           | Min               | Max                | Unit        |
|-------------------------|-------------------------------------------------------|-------------------|--------------------|-------------|
| $BV_{DSS}$              | MOSFET Blocking Voltage                               | ---               | 500                | V           |
| $I_o @ T=25^{\circ}C$   | DC Output Current per MOSFET                          | ---               | 3                  | A           |
| $I_{OP}$                | Pulsed Output Current (Note 1)                        | ---               | 20                 |             |
| $P_d @ T_C=25^{\circ}C$ | Maximum Power Dissipation per MOSFET                  | ---               | 36                 | W           |
| $V_{ISO}$               | Isolation Voltage (1min) (Note 2)                     | ---               | 1500               | $V_{RMS}$   |
| $T_J$                   | Operating Junction Temperature                        | -40               | 150                | $^{\circ}C$ |
| $T_L$                   | Lead Temperature (Soldering, 30 seconds)              | ---               | 260                | $^{\circ}C$ |
| $T_S$                   | Storage Temperature                                   | -40               | 150                | $^{\circ}C$ |
| $V_{S1,2,3}$            | High Side Floating Supply Offset Voltage              | $V_{B1,2,3} - 20$ | $V_{B1,2,3} + 0.3$ | V           |
| $V_{B1,2,3}$            | High Side Floating Supply Voltage                     | -0.3              | 500                | V           |
| $V_{CC}$                | Low Side and Logic Supply voltage                     | -0.3              | 20                 | V           |
| $V_{IN}$                | Input Voltage of LIN, HIN, $I_{TRIP}$ , EN, RCIN, FLT | $V_{SS} - 0.3$    | $V_{CC} + 0.3$     | V           |

Note 1: Pulse Width = 100 $\mu$ s,  $T_C = 25^{\circ}C$ , Duty=1%.

Note 2: Characterized, not tested at manufacturing

## Recommended Operating Conditions

| Symbol              | Description                                            | Min                | Max                | Unit |
|---------------------|--------------------------------------------------------|--------------------|--------------------|------|
| V+                  | Positive DC Bus Input Voltage                          | ---                | 400                | V    |
| V <sub>S1,2,3</sub> | High Side Floating Supply Offset Voltage               | (Note 3)           | 400                | V    |
| V <sub>B1,2,3</sub> | High Side Floating Supply Voltage                      | V <sub>S</sub> +12 | V <sub>S</sub> +20 | V    |
| V <sub>CC</sub>     | Low Side and Logic Supply Voltage                      | 13.5               | 16.5               | V    |
| V <sub>IN</sub>     | Input Voltage of LIN, HIN, I <sub>TRIP</sub> , EN, FLT | 0                  | 5                  | V    |
| F <sub>p</sub>      | PWM Carrier Frequency                                  | ---                | 20                 | kHz  |

The Input/Output logic diagram is shown in Figure 1. For proper operation the module should be used within the recommended conditions. All voltages are absolute referenced to COM. The V<sub>S</sub> offset is tested with all supplies biased at 15V differential.

Note 3: Logic operational for V<sub>S</sub> from COM-5V to COM+250V. Logic state held for V<sub>S</sub> from COM-5V to COM-V<sub>BS</sub>.

## Static Electrical Characteristics

(V<sub>CC</sub>-COM) = (V<sub>B</sub>-V<sub>S</sub>) = 15 V. T<sub>A</sub> = 25°C unless otherwise specified. The V<sub>IN</sub> and I<sub>IN</sub> parameters are referenced to V<sub>SS</sub> and are applicable to all six channels. The V<sub>CCUV</sub> parameters are referenced to V<sub>SS</sub>. The V<sub>BSUV</sub> parameters are referenced to V<sub>S</sub>.

| Symbol                                     | Description                                                                        | Min  | Typ  | Max  | Units | Conditions                                                      |
|--------------------------------------------|------------------------------------------------------------------------------------|------|------|------|-------|-----------------------------------------------------------------|
| BV <sub>DSS</sub>                          | Drain-to-Source Breakdown Voltage                                                  | 500  | ---  | ---  | V     | T <sub>J</sub> =25°C, I <sub>LK</sub> =250μA                    |
| I <sub>LKH</sub>                           | Leakage Current of High Side FET's in Parallel                                     |      | 10   |      | μA    | T <sub>J</sub> =25°C, V <sub>DS</sub> =500V                     |
| I <sub>LKL</sub>                           | Leakage Current of Low Side FET's in Parallel Plus Gate Drive IC                   |      | 15   |      | μA    | T <sub>J</sub> =25°C, V <sub>DS</sub> =500V                     |
| R <sub>DS(ON)</sub>                        | Drain to Source ON Resistance                                                      | ---  | 1.85 | 2.2  | Ω     | T <sub>J</sub> =25°C, V <sub>CC</sub> =15V, I <sub>d</sub> = 1A |
| V <sub>IN,th+</sub>                        | Positive Going Input Threshold                                                     | 2.5  | ---  | ---  | V     |                                                                 |
| V <sub>IN,th-</sub>                        | Negative Going Input Threshold                                                     | ---  | ---  | 0.8  | V     |                                                                 |
| V <sub>CCUV+</sub> ,<br>V <sub>BSUV+</sub> | V <sub>CC</sub> and V <sub>BS</sub> Supply Under-Voltage, Positive Going Threshold | 8    | 8.9  | 9.8  | V     |                                                                 |
| V <sub>CCUV-</sub> ,<br>V <sub>BSUV-</sub> | V <sub>CC</sub> and V <sub>BS</sub> supply Under-Voltage, Negative Going Threshold | 7.4  | 8.2  | 9    | V     |                                                                 |
| V <sub>CCUVH</sub> ,<br>V <sub>BSUVH</sub> | V <sub>CC</sub> and V <sub>BS</sub> Supply Under-Voltage Lock-Out Hysteresis       | ---  | 0.7  | ---  | V     |                                                                 |
| I <sub>QBS</sub>                           | Quiescent V <sub>BS</sub> Supply Current V <sub>IN</sub> =0V                       | ---  | ---  | 125  | μA    |                                                                 |
| I <sub>QCC</sub>                           | Quiescent V <sub>CC</sub> Supply Current V <sub>IN</sub> =0V                       | ---  | ---  | 3.35 | mA    |                                                                 |
| I <sub>QCC, ON</sub>                       | Quiescent V <sub>CC</sub> Supply Current V <sub>IN</sub> =4V                       | ---  | ---  | 10   | mA    |                                                                 |
| I <sub>IN+</sub>                           | Input Bias Current V <sub>IN</sub> =4V                                             | ---  | 100  | 160  | μA    |                                                                 |
| I <sub>IN-</sub>                           | Input Bias Current V <sub>IN</sub> =0V                                             | ---  | --   | 1    | μA    |                                                                 |
| I <sub>TRIP+</sub>                         | I <sub>TRIP</sub> Bias Current V <sub>ITRIP</sub> =4V                              | ---  | 5    | 40   | μA    |                                                                 |
| I <sub>TRIP-</sub>                         | I <sub>TRIP</sub> Bias Current V <sub>ITRIP</sub> =0V                              | ---  | --   | 1    | μA    |                                                                 |
| V <sub>IT, TH+</sub>                       | I <sub>TRIP</sub> Threshold Voltage                                                | 0.37 | 0.46 | 0.55 | V     |                                                                 |
| V <sub>IT, TH-</sub>                       | I <sub>TRIP</sub> Threshold Voltage                                                | ---  | 0.4  | ---  | V     |                                                                 |

|                 |                                              |     |      |     |          |                          |
|-----------------|----------------------------------------------|-----|------|-----|----------|--------------------------|
| $V_{IT, HYS}$   | $I_{TRIP}$ Input Hysteresis                  | --- | 0.06 | --- | V        |                          |
| $R_{BR}$        | Internal Bootstrap Equivalent Resistor Value | --- | 200  | --- | $\Omega$ | $T_J=25^{\circ}\text{C}$ |
| $V_{RCIN, TH}$  | RCIN Positive Going Threshold                | --- | 8    | --- | V        |                          |
| $R_{ON, FAULT}$ | FAULT Open-Drain Resistance                  | --- | 50   | 100 | $\Omega$ |                          |

Note 4: Characterized, not tested at manufacturing

## Dynamic Electrical Characteristics

( $V_{CC-COM}$ ) = ( $V_B-V_S$ ) = 15 V.  $T_A = 25^{\circ}\text{C}$  unless otherwise specified.

| Symbol          | Description                                     | Min | Typ | Max  | Units         | Conditions                                               |
|-----------------|-------------------------------------------------|-----|-----|------|---------------|----------------------------------------------------------|
| $T_{ON}$        | Input to Output Propagation Turn-On Delay Time  | --- | 0.7 | 1.5  | $\mu\text{s}$ | $I_D=1\text{mA}$ , $V^+=50\text{V}$<br>See Fig.2         |
| $T_{OFF}$       | Input to Output Propagation Turn-Off Delay Time | --- | 0.7 | 1.5  | $\mu\text{s}$ |                                                          |
| $T_{FIL, IN}$   | Input Filter Time (HIN, LIN)                    | 200 | 330 | ---  | ns            | $V_{IN}=0$ & $V_{IN}=4\text{V}$                          |
| $T_{FIL, EN}$   | Input Filter Time (EN)                          | 100 | 200 | ---  | ns            | $V_{IN}=0$ & $V_{IN}=4\text{V}$                          |
| $T_{BLT-ITRIP}$ | $I_{TRIP}$ Blanking Time                        | 100 | 330 |      | ns            | $V_{IN}=0$ & $V_{IN}=4\text{V}$ , $V_{I/TRIP}=5\text{V}$ |
| $T_{FAULT}$     | $I_{trip}$ to Fault                             | --- | 600 | 1000 | ns            | $V_{IN}=0$ & $V_{IN}=4\text{V}$                          |
| $T_{EN}$        | EN Falling to Switch Turn-Off                   |     | 700 | 1000 | ns            | $V_{IN}=0$ & $V_{IN}=4\text{V}$                          |
| $T_{ITRIP}$     | $I_{TRIP}$ to Switch Turn-Off Propagation Delay | --- | 950 | 1300 | ns            | $I_D=1\text{A}$ , $V^+=50\text{V}$ , See Figure 3        |

## MOSFET Avalanche Characteristics

| Symbol | Description                   | Min | Typ | Max | Units | Conditions                                                                                                     |
|--------|-------------------------------|-----|-----|-----|-------|----------------------------------------------------------------------------------------------------------------|
| EAS    | Single Pulse Avalanche Energy | --- | 150 | --- | mJ    | $T_J=25^{\circ}\text{C}$ , $L=93\text{mH}$ , $V_{DD}=150\text{V}$ ,<br>$I_{TEST}=1.8\text{A}$ , TO-220 package |

## Thermal and Mechanical Characteristics

| Symbol         | Description                                      | Min | Typ  | Max | Units                | Conditions |
|----------------|--------------------------------------------------|-----|------|-----|----------------------|------------|
| $R_{th(J-CT)}$ | Total Thermal Resistance Junction to Case Top    | --- | 27.4 | --- | $^{\circ}\text{C/W}$ | One device |
| $R_{th(J-CB)}$ | Total Thermal Resistance Junction to Case Bottom | --- | 2.2  | --- | $^{\circ}\text{C/W}$ | One device |

**Qualification Information†**

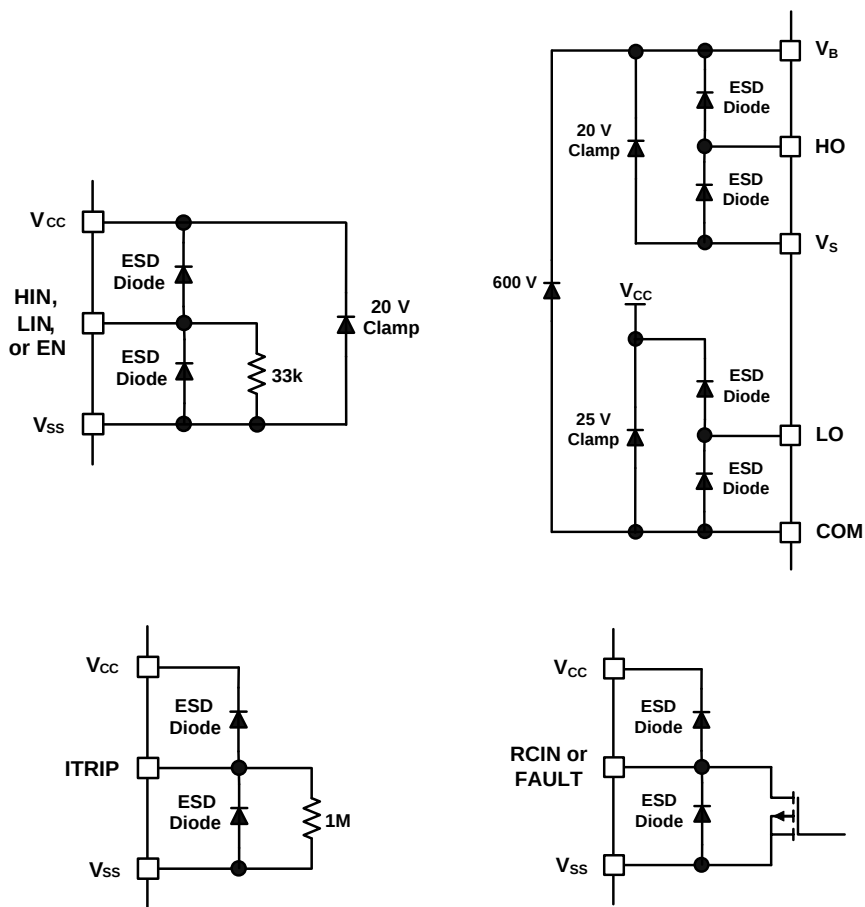
|                                   |                         |                                                   |
|-----------------------------------|-------------------------|---------------------------------------------------|
| <b>Qualification Level</b>        |                         | Industrial <sup>††</sup><br>(per JEDEC JESD 47E)  |
| <b>Moisture Sensitivity Level</b> |                         | MSL3 <sup>†††</sup><br>(per IPC/JEDEC J-STD-020C) |
| <b>ESD</b>                        | <b>Machine Model</b>    | Class B<br>(per JEDEC standard JESD22-A115)       |
|                                   | <b>Human Body Model</b> | Class 2<br>(per standard ESDA/JEDEC JS-001-2012)  |
| <b>RoHS Compliant</b>             |                         | Yes                                               |

† Qualification standards can be found at International Rectifier's web site <http://www.irf.com/>

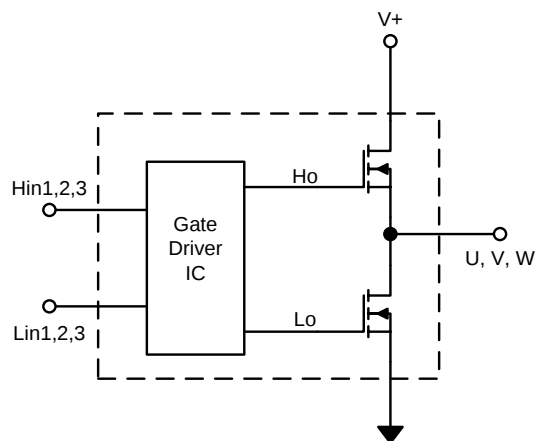
†† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information.

††† Higher MSL ratings may be available for the specific package types listed here. Please contact your International Rectifier sales representative for further information.

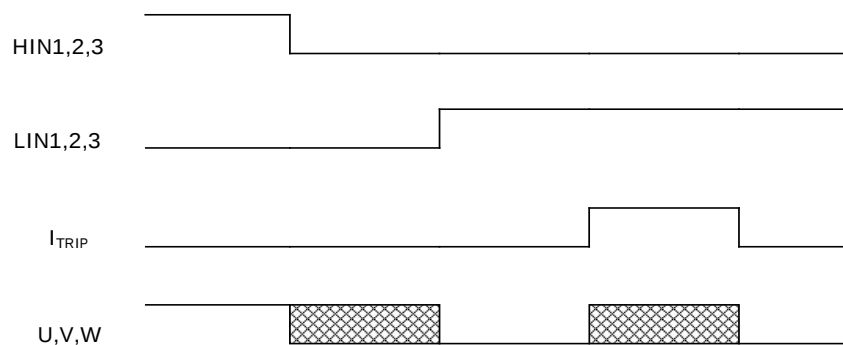
# Input/ Output Pin Equivalent Circuit Diagrams



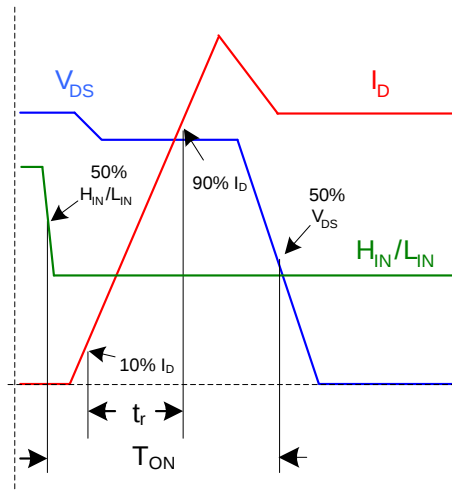
# Input-Output Logic Level Table



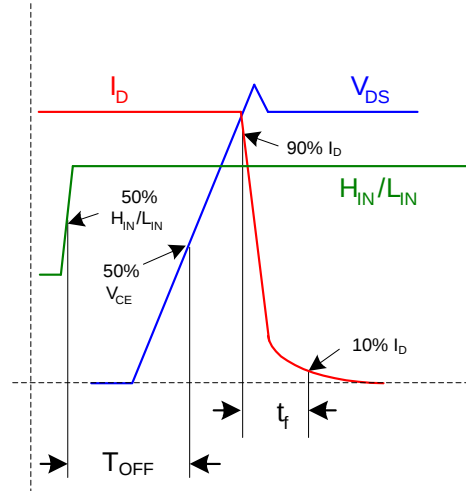
| EN | Itrip | Hin1,2,3 | Lin1,2,3 | U,V,W |
|----|-------|----------|----------|-------|
| 1  | 0     | 1        | 0        | V+    |
| 1  | 0     | 0        | 1        | 0     |
| 1  | 0     | 0        | 0        | off   |
| 1  | 1     | X        | X        | off   |
| 0  | X     | X        | X        | off   |



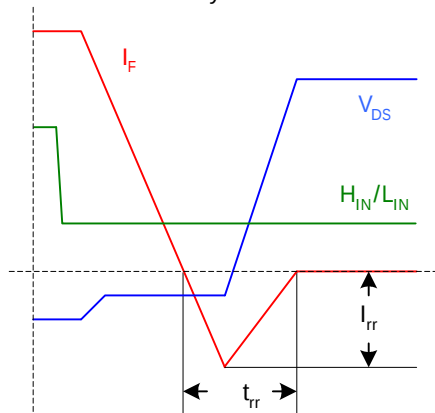
**Figure 1:** Input/Output Logic Diagram



**Figure 2a:** Input to Output propagation turn-on delay time.

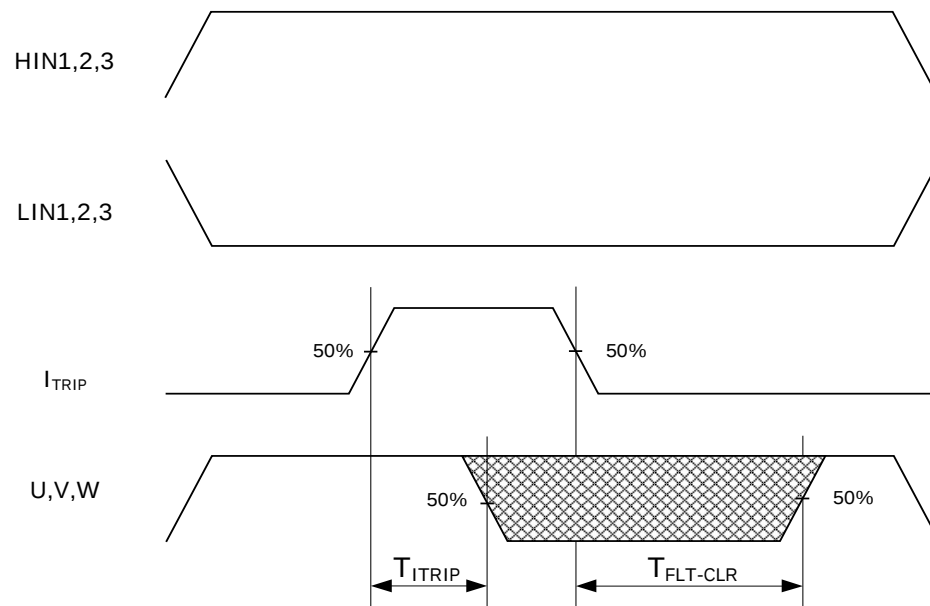


**Figure 2b:** Input to Output propagation turn-off delay time.



**Figure 2c:** Diode Reverse Recovery.

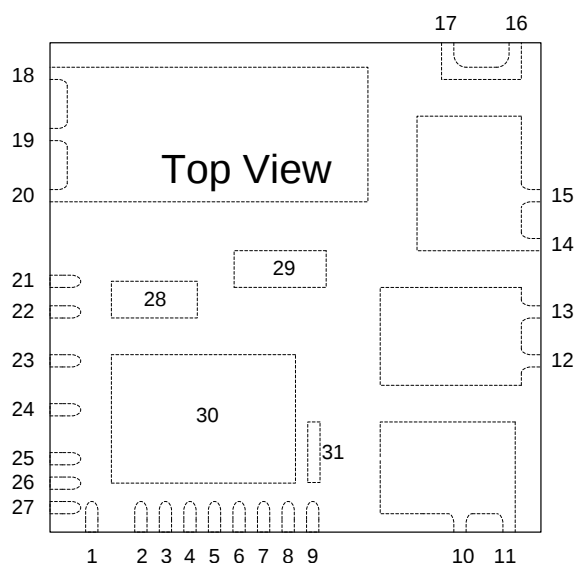
**Figure 2:** Switching Parameter Definitions



**Figure 3:**  $I_{TRIP}$  Timing Waveform

## Module Pin-Out Description

| Pin            | Name              | Description                                         |
|----------------|-------------------|-----------------------------------------------------|
| 1              | HIN3              | Logic Input High Side Gate Driver - Phase 3         |
| 2              | LIN1              | Logic Input Low Side Gate Driver - Phase 1          |
| 3              | LIN2              | Logic Input Low Side Gate Driver - Phase 2          |
| 4              | LIN3              | Logic Input Low Side Gate Driver - Phase 3          |
| 5              | /FLT              | Fault Output                                        |
| 6              | I <sub>TRIP</sub> | Current Protection Pin                              |
| 7              | EN                | Enable Pin                                          |
| 8              | RCIN              | RCIN Reset Programming Pin                          |
| 9              | V <sub>SS</sub>   | Negative Main Supply                                |
| 10, 11, 21, 28 | U,VS1             | Output 1 - High Side Floating Supply Offset Voltage |
| 12, 13, 29     | V,VS2             | Output 2 - High Side Floating Supply Offset Voltage |
| 14, 15         | W,VS3             | Output 3 - High Side Floating Supply Offset Voltage |
| 16, 17, 30, 31 | V-                | Negative Bus Input Voltage, COM                     |
| 18, 19, 20     | V <sup>+</sup>    | Positive Bus Input Voltage                          |
| 22             | VB1               | High Side Floating Supply voltage 1                 |
| 23             | VB2               | High Side Floating Supply voltage 2                 |
| 24             | VB3               | High Side Floating Supply Voltage 3                 |
| 25             | V <sub>CC</sub>   | +15V Main Supply                                    |
| 26             | HIN1              | Logic Input High Side Gate Driver - Phase 1         |
| 27             | HIN2              | Logic Input High Side Gate Driver - Phase 2         |



### Notes

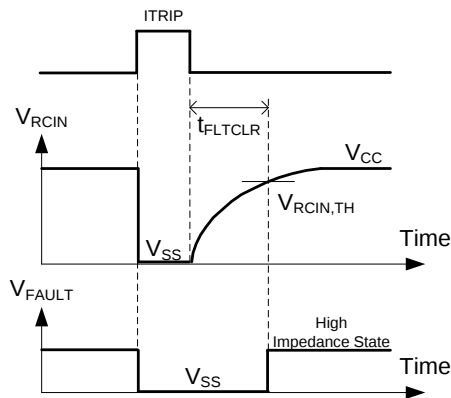
Pin 28,29, 31 are not required to be connected electrically on the PCB

All pins with the same name are internally connected. For example, pins 10, 11, 21 and 28 are internally connected.

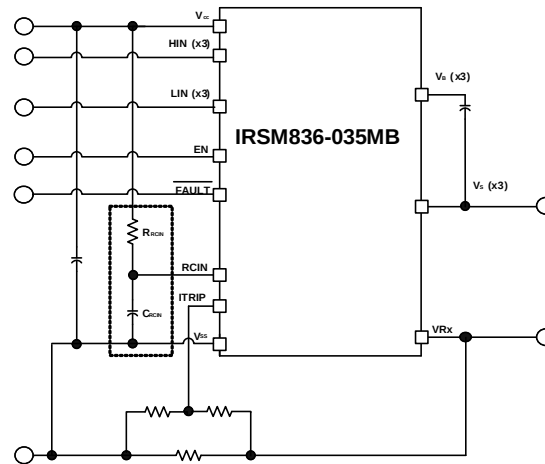
## Fault Reporting and Programmable Fault Clear Timer

The IRSM836-035MB provides an integrated fault reporting output and an adjustable fault clear timer. There are two situations that would cause the IRSM836-035MB to report a fault via the FAULT pin. The first is an under-voltage condition of  $V_{CC}$  and the second is when the ITRIP pin recognizes a fault. Once the fault condition occurs, the FAULT pin is internally pulled to  $V_{SS}$  and the fault clear timer is activated. The fault output stays in the low state until the fault condition has been removed and the fault clear timer expires; once the fault clear timer expires, the voltage on the FAULT pin will return to  $V_{CC}$ .

The length of the fault clear time period ( $t_{FLTCLR}$ ) is determined by exponential charging characteristics of the capacitor where the time constant is set by  $R_{RCIN}$  and  $C_{RCIN}$ . In Figure 4 where we see that a fault condition has occurred (UVLO or ITRIP),  $RCIN$  and  $FAULT$  are pulled to  $V_{SS}$ , and once the fault has been removed, the fault clear timer begins. Figure 5 shows that  $R_{RCIN}$  is connected between the  $V_{CC}$  and the  $RCIN$  pin, while  $C_{RCIN}$  is placed between the  $RCIN$  and  $V_{SS}$  pins.



**Figure 4:** RCIN and FAULT pin waveforms



**Figure 5:** Programming the fault clear timer

The design guidelines for this network are shown in Table 1.

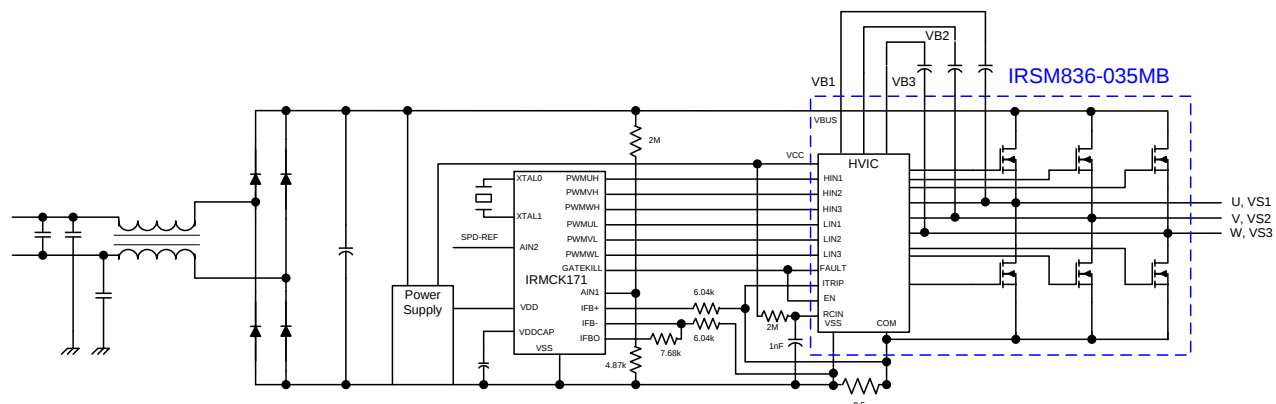
|            |                                                     |
|------------|-----------------------------------------------------|
| $C_{RCIN}$ | $\leq 1 \text{ nF}$                                 |
|            | Ceramic                                             |
| $R_{RCIN}$ | $0.5 \text{ M}\Omega \text{ to } 2 \text{ M}\Omega$ |
|            | $\gg R_{ON,RCIN}$                                   |

**Table 1:** Design guidelines

The length of the fault clear time period can be determined by using the formula below.

$$t_{FLTCLR} = -(R_{RCIN} C_{RCIN}) \ln \left( 1 - \frac{V_{RCIN,TH}}{V_{CC}} \right)$$

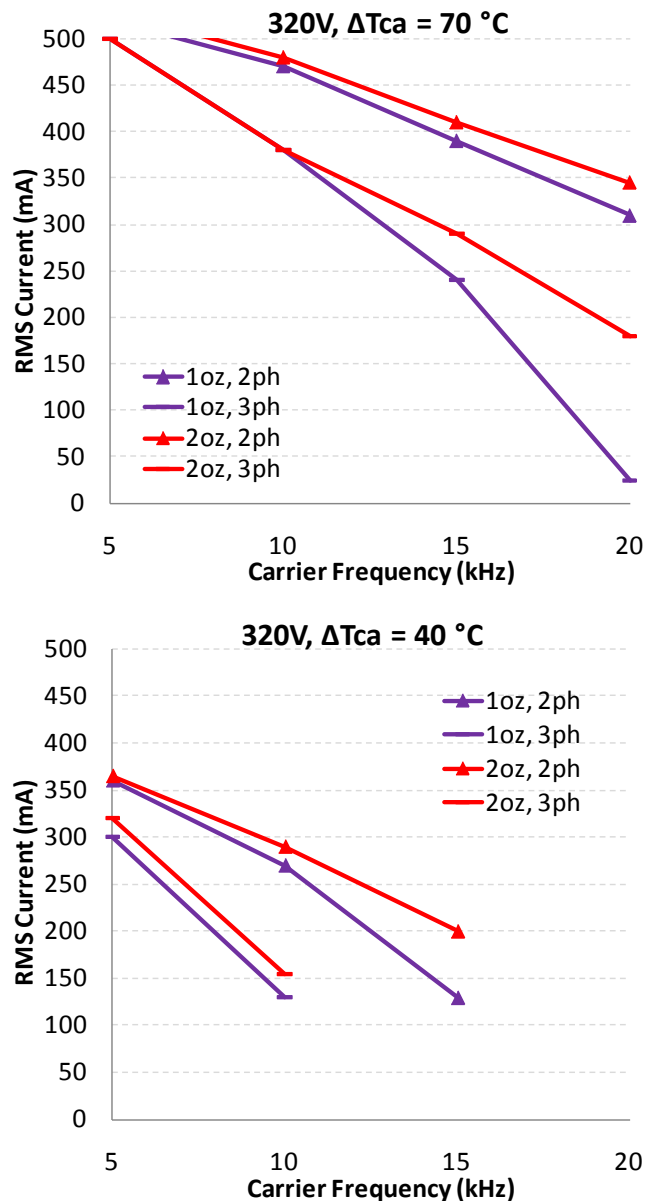
## Typical Application Connection IRSM836-035MB



1. Electrolytic bus capacitors should be mounted as close to the module bus terminals as possible to reduce ringing and EMI problems. Additional high frequency ceramic capacitor mounted close to the module pins will further improve performance.
2. In order to provide good decoupling between VCC-VSS and VB1,2,3-VS1,2,3 terminals, the capacitors shown connected between these terminals should be located very close to the module pins. Additional high frequency capacitors, typically 0.1μF, are recommended.
3. Value of the boot-strap capacitors depends upon the switching frequency. Their selection should be made based on application note AN-1044.
4. PWM generator must be disabled within Fault duration to guarantee shutdown of the system. Over-current condition must be cleared before resuming operation.

## Current Capability in a Typical Application

Figure 6 shows the current capability for this module at specified conditions. The current capability of the module is affected by application conditions including the PCB layout, ambient temperature, maximum PCB temperature, modulation scheme, PCB copper thickness and so on. The curves below were obtained from measurements carried out on the IRMCS1171 reference design board which includes the IRSM836-035MB and IR's IRMCK171 digital control IC.



**Figure 6:** Maximum Sinusoidal Phase Current vs. PWM Switching Frequency  
Sinusoidal Modulation,  $V^+ = 320\text{V}$ ,  $\text{PF} = 0.95$

## PCB Example

Figure 7 below shows an example layout for the application PCB. The effective area of the V+ top-layer copper plane is  $\sim 3\text{cm}^2$  in this example. For an FR4 PCB with 1oz copper,  $R_{\text{th(J-A)}}$  is about  $40^\circ\text{C/W}$ . A lower  $R_{\text{th(J-A)}}$  can be achieved using thicker copper and/or additional layers.

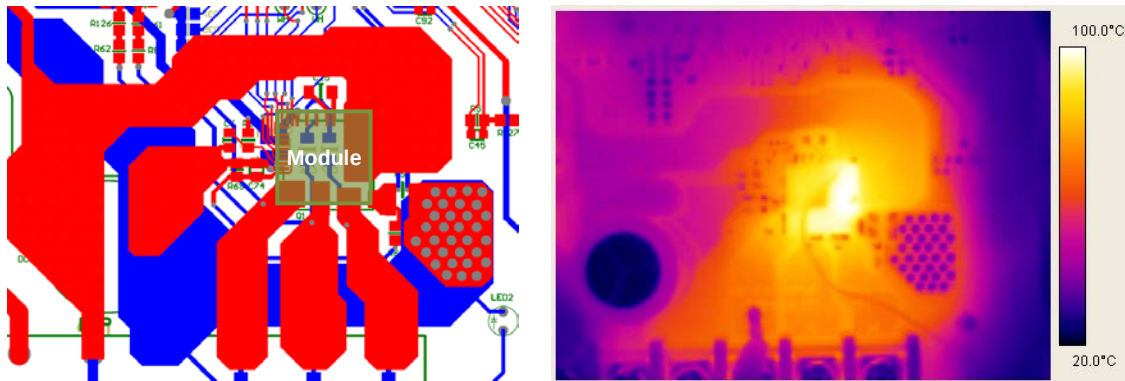
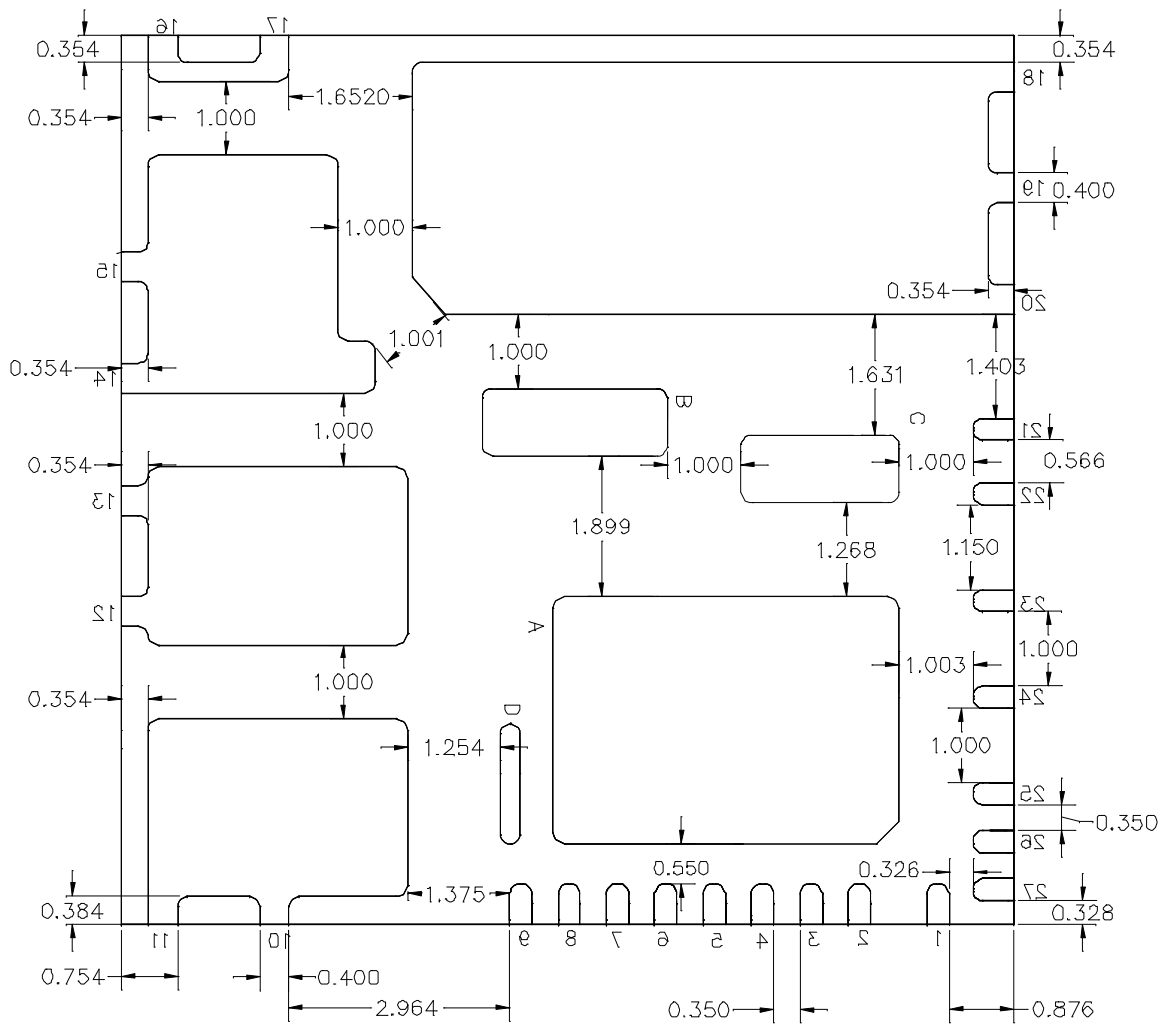
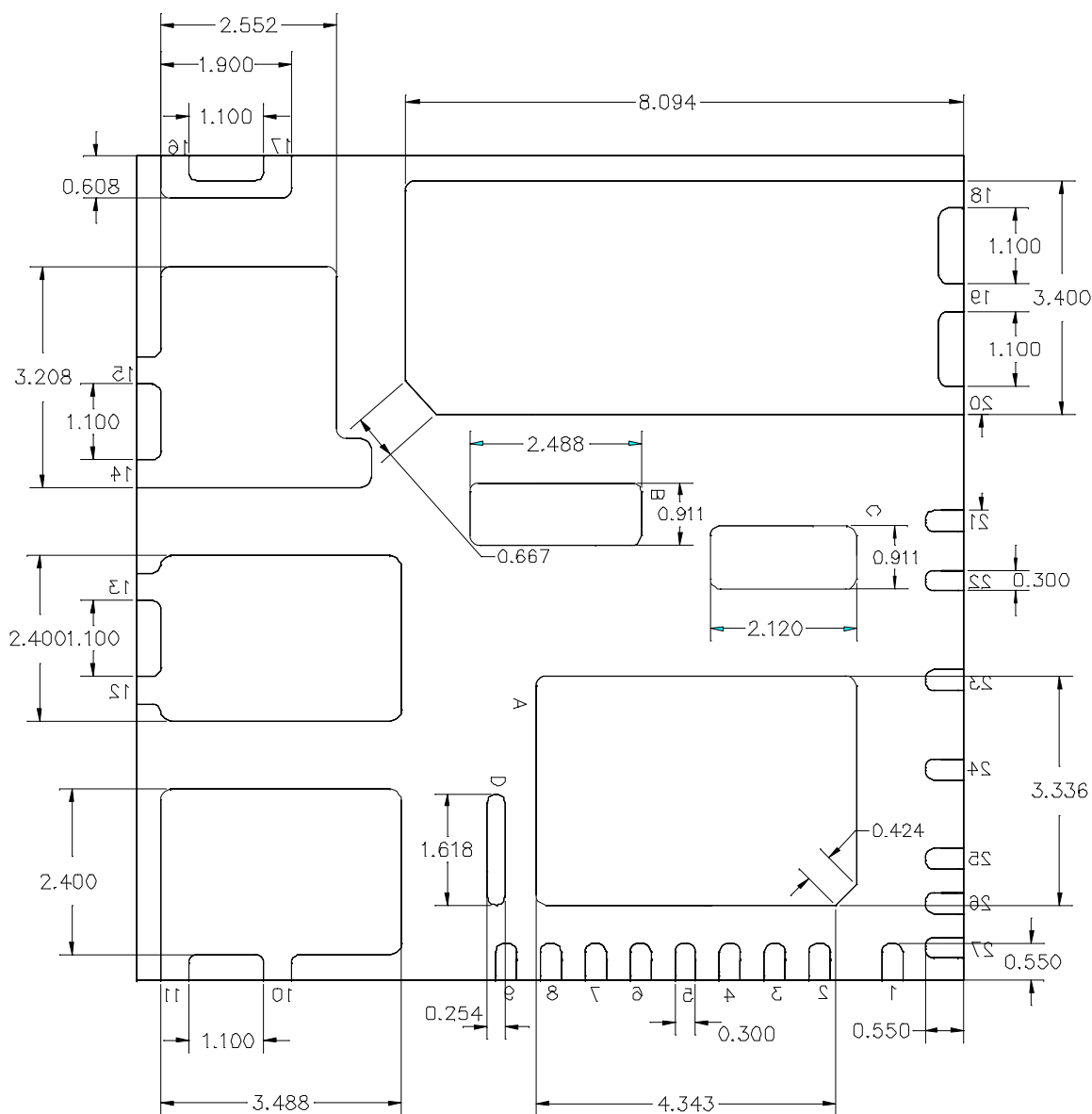


Figure 7: PCB layout example and corresponding thermal image

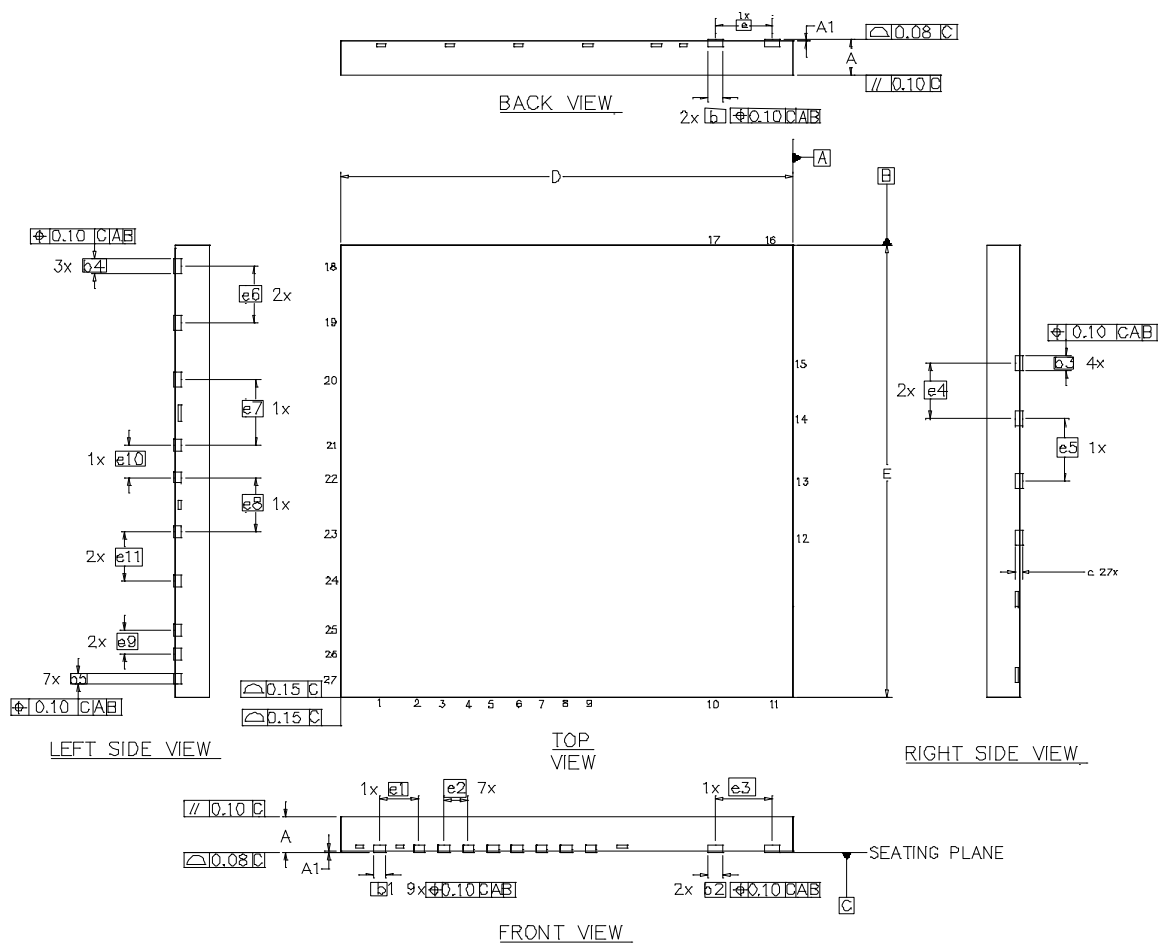
At the module's typical operating conditions,  $dV/dt$  of the phase node voltage is influenced by the load capacitance which includes parasitic capacitance of the PCB, MOSFET output capacitance and motor winding capacitance. To turn off the MOSFET, the load capacitance needs to be charged by the phase current. For the IRMCS1171 reference design, turn-off  $dV/dt$  ranges from 2 to 5 V/ns depending on the phase current magnitude. Turn-on  $dV/dt$  is influenced by PCB parasitic capacitance and motor winding capacitance and typically ranges from 4 to 6 V/ns. The MOSFET turn-on loss combined with the complimentary body diode reverse recovery loss comprises the majority of the total switching losses. Two-phase modulation can be used to reduce switching losses and run the module at higher phase currents.

**27L Package Outline IRSM836-035MB (Bottom View)**


Dimensions in mm

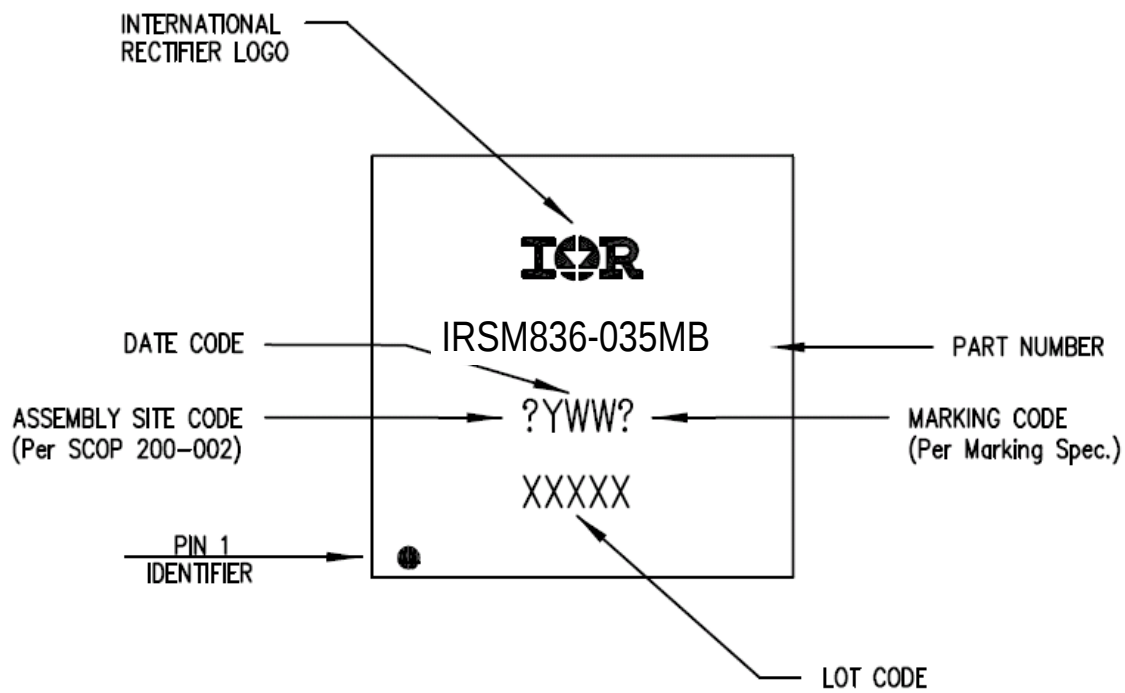
**27L Package Outline IRSM836-035MB (Bottom View)**


Dimensions in mm

**27L Package Outline IRSM836-035MB (Top and Side View)**


| DIM | MILLIMETERS |       |
|-----|-------------|-------|
|     | MIN         | MAX   |
| A   | 0.800       | 1.000 |
| A1  | 0.000       | 0.050 |
| b   | 0.350       | 0.450 |
| b1  | 0.250       | 0.350 |
| b2  | 0.250       | 0.350 |
| b3  | 0.350       | 0.450 |
| b4  | 0.350       | 0.450 |
| b5  | 0.250       | 0.350 |
| c   | 0.203       | REF.  |
| D   | 12.000      | BASIC |
| E   | 12.000      | BASIC |

|     |       |       |
|-----|-------|-------|
| e   | 1.500 | BASIC |
| e1  | 1.056 | BASIC |
| e2  | 0.650 | BASIC |
| e3  | 1.500 | BASIC |
| e4  | 1.500 | BASIC |
| e5  | 1.650 | BASIC |
| e6  | 1.500 | BASIC |
| e7  | 1.753 | BASIC |
| e8  | 1.450 | BASIC |
| e9  | 0.650 | BASIC |
| e10 | 0.866 | BASIC |
| e11 | 1.300 | BASIC |

**27L Top Marking**


## Revision History

|                  |                                                                                                                                 |
|------------------|---------------------------------------------------------------------------------------------------------------------------------|
| January 30, 2013 | Formatting corrections; added notes about what pins are internally connected; updated ordering table stating all parts are PbF. |
|------------------|---------------------------------------------------------------------------------------------------------------------------------|

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Data and Specifications are subject to change without notice  
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